

Notice of References Cited

Application/Control No.

09/693,268

Applicant(s)/Patent Under
Reexamination
BASKEY ET AL.

Examiner

Thu Ha T. Nguyen

Art Unit

2155

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,594,699 B1	07-2003	Sahai et al.	709/228
	B	US-2003/0191829 A1	10-2003	Masters et al.	709/223
	C	US-6,678,518 B2	01-2004	Eerola, Severi	455/422.1
	D	US-6,253,248 B1	06-2001	Nakai et al.	709/237
	E	US-2002/0152307 A1	10-2002	Doyle et al.	709/225
	F	US-2002/0091802 A1	07-2002	Paul et al.	709/220
	G	US-6,449,647 B1	09-2002	Colby et al.	709/226
	H	US-6,006,264 A	12-1999	Colby et al.	709/226
	I	US-6,212,546 B1	04-2001	Starkovich et al.	709/203
	J	US-5,812,768 A	09-1998	Page et al.	709/228
	K	US-2002/0124100 A1	09-2002	Adams, Jeffrey B	709/232
	L	US-6,553,413 B1	04-2003	Leighton et al.	709/219
	M	US-2002/0019879	02-2002	Jasen et al.	709/240

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.